

UNISONIC TECHNOLOGIES CO., LTD

4NM45

Preliminary

4.0A, 450V N-CHANNEL SUPER-JUNCTION MOSFET

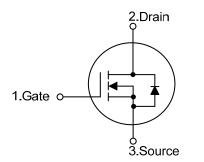
DESCRIPTION

The UTC **4NM45** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at AC-DC converters for power applications.

■ FEATURES0

- * $R_{DS(ON)} \leq 1.42 \ \Omega @ V_{GS}=10V, I_D=2.0A$
- * Low on-resistance
- * High Switching Speed
- * 100% Avalanche Tested

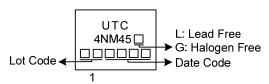
SYMBOL

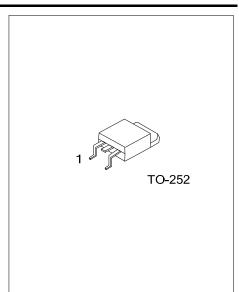


ORDERING INFORMATION

Ordering Number		Deekege	Pin Assignment			Deaking		
Lead Free	Halogen Free	Package	1	2	3	Packing		
4NM45L-TN3-R	4NM45G-TN3-R	TO-252	G	D	S	Tape Reel		
Note: Pin Assignment: G: Gate D: Drain S: Source								
4NM45G-TN3-R								
(1)Packing Type (2)Package Type		(1) R: Tape F	(1) R: Tape Reel					
		(2) TN3: TO-	(2) TN3: TO-252					
(3)Green Package		(3) G: Halogen Free and Lead Free, L: Lead Free						

MARKING





■ **ABSOLUTE MAXIMUM RATINGS** (T_c=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	450	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Current	Continuous	I _D	4	А
	Pulsed (Note 2)	I _{DM}	12	А
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	144	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	2.4	V/ns
Power Dissipation		PD	14	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 144mH, I_{AS} = 1.4A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

4. $I_{SD} \le 4.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	θ _{JC}	8.93	°C/W	

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

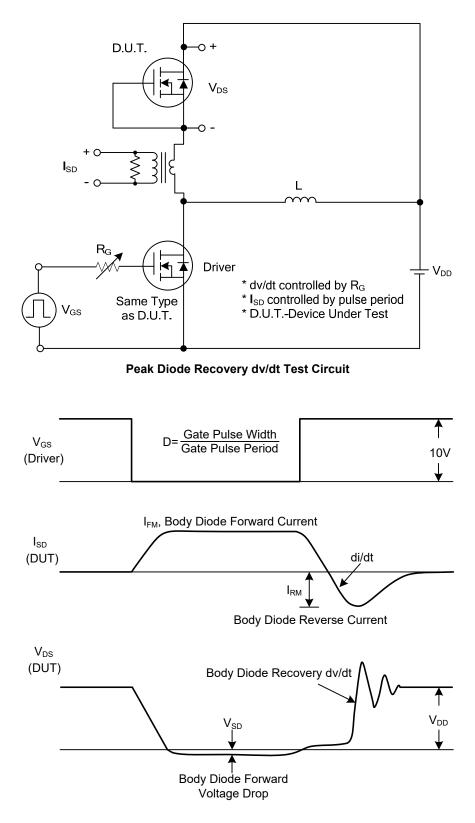
■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified

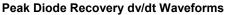
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250µA	450			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =450V, V _{GS} =0V			10	μA
Gate-Source Leakage Current	I _{GSS}	V_{GS} =±30V, V_{DS} =0V			±100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =2.0A			1.42	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{ISS}			142		pF
Output Capacitance	C _{oss}	V _{DS} =50V, V _{GS} =0V, f=1MHz		89		pF
Reverse Transfer Capacitance		7		10		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge (Note 1)	Q_{G}			13		nC
Gate-Source Charge	Q_{GS}	−V _{DS} =50V, V _{GS} =10V, I _D =2.0A −Note 1, 2)		4		nC
Gate-Drain Charge	Q_{GD}			4		nC
Turn-On Delay Time (Note 1)	t _{D(ON)}			7		ns
Turn-On Rise Time	t _R	V _{DD} =100V, V _{GS} =10V,		20		ns
Turn-Off Delay Time	t _{D(OFF)}	I _D =4.0A, R _G =25Ω (Note 1, 2)		21		ns
Turn-Off Fall Time	t _F	7		21		ns
SOURCE- DRAIN DIODE RATINGS AND CH	ARACTERIST	ICS				
Maximum Continuous Drain-Source Diode					4	А
Forward Current	l _S				4	A
Maximum Pulsed Drain-Source Diode	I _{SM}				12	А
Forward Current	ISM				12	A
Drain-Source Diode Forward Voltage (Note 1)	V _{SD}	I _S =4.0A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)	t _{rr}	I _S =4.0A, V _{GS} =0V,		174		nS
Body Diode Reverse Recovery Charge	Q _{rr}	dI _F /dt=100A/µs				μC
Notes: 1. Pulse Test: Pulse width \leq 300µs, Du	ty cycle $\leq 2\%$					

2. Essentially independent of operating temperature.



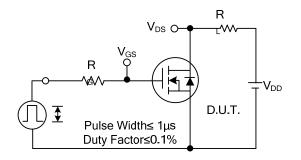
TEST CIRCUITS AND WAVEFORMS



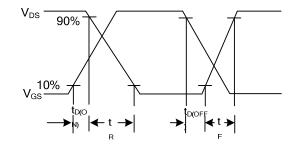


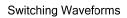


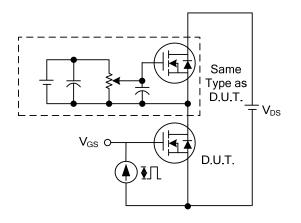
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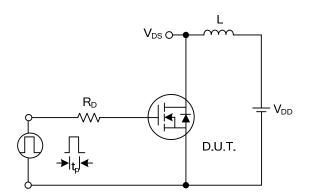
Switching Test Circuit



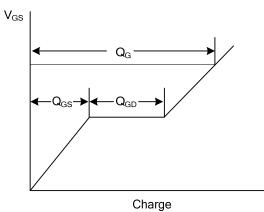




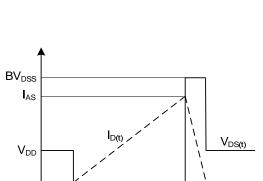
Gate Charge Test Circuit



Unclamped Inductive Switching Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Waveforms

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Time

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